# FAIRCHILD

SEMICONDUCTOR

## **FDMS0308CS** N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup> 30 V, 42 A, 3 m $\Omega$

### Features

- Max  $r_{DS(on)}$  = 3.0 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 21 A
- Max  $r_{DS(on)}$  = 3.5 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 17 A
- Advanced Package and Silicon combination for low r<sub>DS(on)</sub> and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

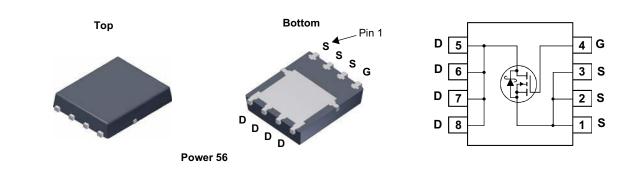


### **General Description**

The FDMS0308CS has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

### Applications

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/ GPU low side switch
- Networking Point of Load low side switch
- Desktop



### MOSFET Maximum Ratings T<sub>C</sub> = 25 °C unless otherwise noted

Symbol	Parameter		Ratings	Units			
V <sub>DS</sub>	Drain to Source Voltage			30	V		
V <sub>GS</sub>	Gate to Source Voltage		(Note 4)	±20	V		
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C		42			
,	-Continuous (Silicon limited)	T <sub>C</sub> = 25 °C		113	•		
D	-Continuous T <sub>A</sub> = 25 °C (Note 1a)		(Note 1a)	22	— A		
	-Pulsed			150			
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	98	mJ		
D	Power Dissipation	T <sub>C</sub> = 25 °C		65	w		
PD	Power Dissipation $T_A = 25 \degree C$ (Note 1a)		2.5	- VV			
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C		

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	1.9	°C/M	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a	) 50	°C/W	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS0308CS	FDMS0308CS	Power 56	13 "	12 mm	3000 units

August 2010

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	octeristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 10 mA, referenced to 25 °C		14		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			500	μA
I <sub>GSS</sub>	Gate to Source Leakage Current, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
On Chara	cteristics (Note 2)					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$	1.2	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 10 mA, referenced to 25 °C		-5		mV/°C
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 21 A		1.9	3.0	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 17 A		2.5	3.5	mΩ
		$V_{GS}$ = 10 V, I <sub>D</sub> = 21 A, T <sub>J</sub> = 125 °C		2.5	3.8	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 21 A		300		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	V 45.V.V. 6.V.		3175	4225	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1175	1565	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			110	165	pF
R <sub>g</sub>	Gate Resistance			1.3	2.6	Ω
Switching	g Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time			14	25	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 21 A,		6	12	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		35	56	ns
t <sub>f</sub>	Fall Time			5	10	ns
Qg	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V		47	66	nC
Qg	Total Gate Charge	$V_{GS}$ = 0 V to 4.5 V $V_{DD}$ = 15 V,		22	31	nC
Q <sub>as</sub>	Gate to Source Gate Charge	I <sub>D</sub> = 21 A		8.5		nC

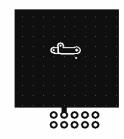
### Switching Characteristic

t <sub>d(on)</sub>	Turn-On Delay Time		14	25	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 21 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω	6	12	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω	35	56	ns
t <sub>f</sub>	Fall Time		5	10	ns
Qg	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V	47	66	nC
Qg	Total Gate Charge	$V_{GS} = 0 V \text{ to } 4.5 V V_{DD} = 15 V,$	22	31	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	I <sub>D</sub> = 21 A	8.5		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge		4.9		nC

### **Drain-Source Diode Characteristics**

$v_{GS} - 0.7, v_{S} - 21.4$ (Note 2) $0.75$ $t_{rr}$ Reverse Recovery Time $l_r = 21.4$ , di/dt = 300 A/ us35	V <sub>SD</sub> Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2 A$ (Note 2)		0.43	0.7	V
$I_{r} = 21 \text{ A} \cdot \text{di/dt} = 300 \text{ A/ }\mu\text{s}$	V <sub>SD</sub> Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 21 A$ (Note 2)		0.75	1.2	v
$I_{\rm E} = 21$ A, $U/U_{\rm L} = 300$ A/ $\mu$ S	t <sub>rr</sub> Reverse Recovery Time	I <sub>F</sub> = 21 A, di/dt = 300 A/ μs		35	56	ns
Qrr Reverse Recovery Charge 41 6				41	67	nC

Notes: 1. R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

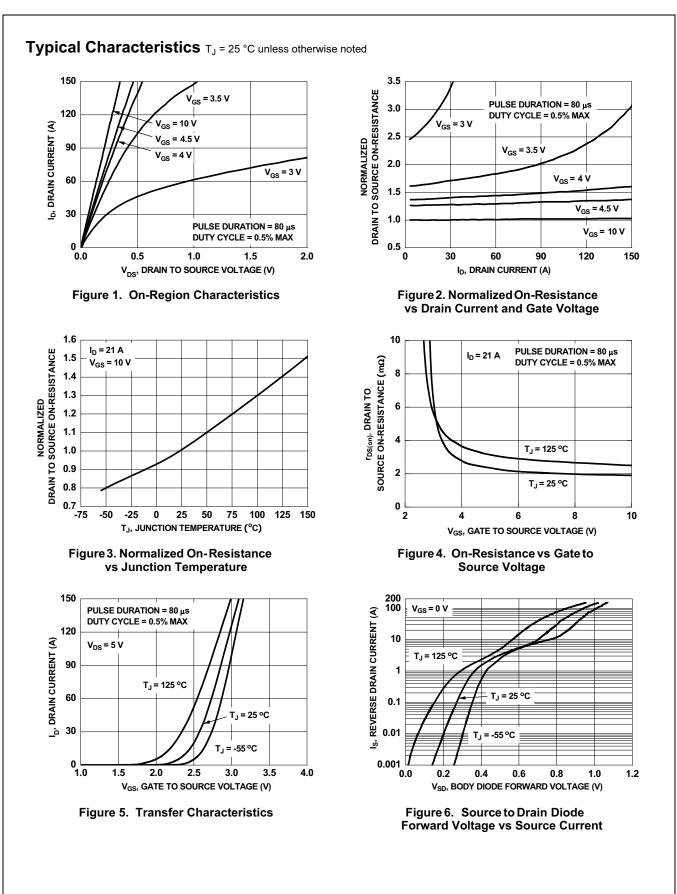


2. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.

3.  $E_{AS}$  of 98 mJ is based on starting  $T_J$  = 25 °C, L = 1 mH,  $I_{AS}$  = 14 A,  $V_{DD}$  = 27 V,  $V_{GS}$  = 10 V. 100% test at L = 0.3 mH,  $I_{AS}$  = 21 A.

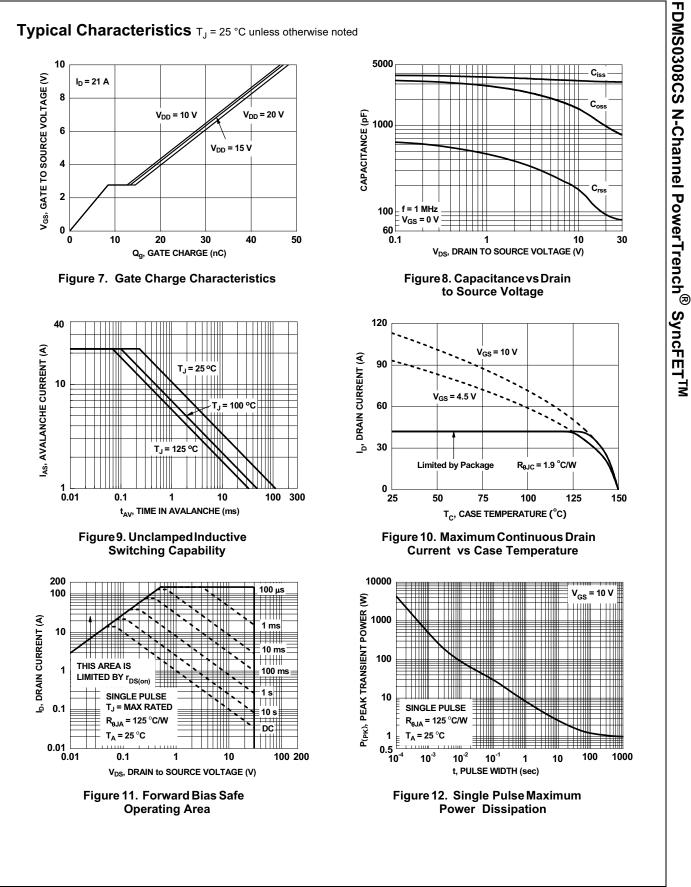
4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

FDMS0308CS N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup>



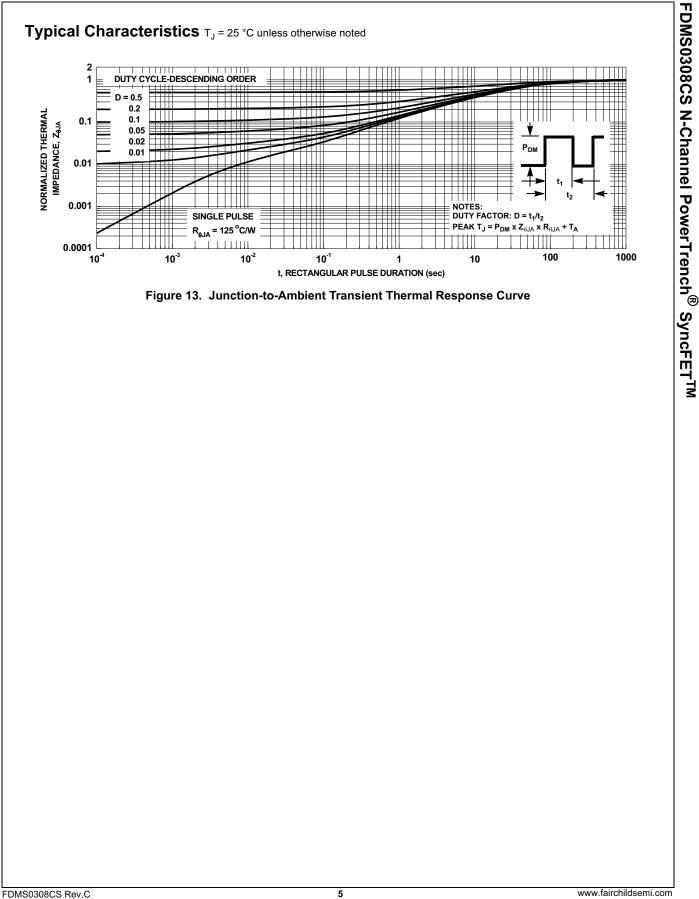
FDMS0308CS Rev.C

www.fairchildsemi.com



FDMS0308CS Rev.C

www.fairchildsemi.com



# FDMS0308CS N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup>

### Typical Characteristics (continued)

### SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MoSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverses recovery characteristic of the FDMS0308CS.

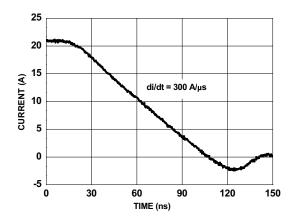
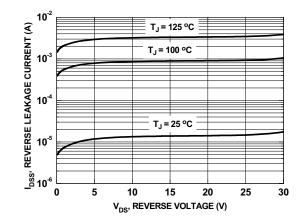
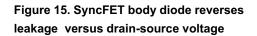
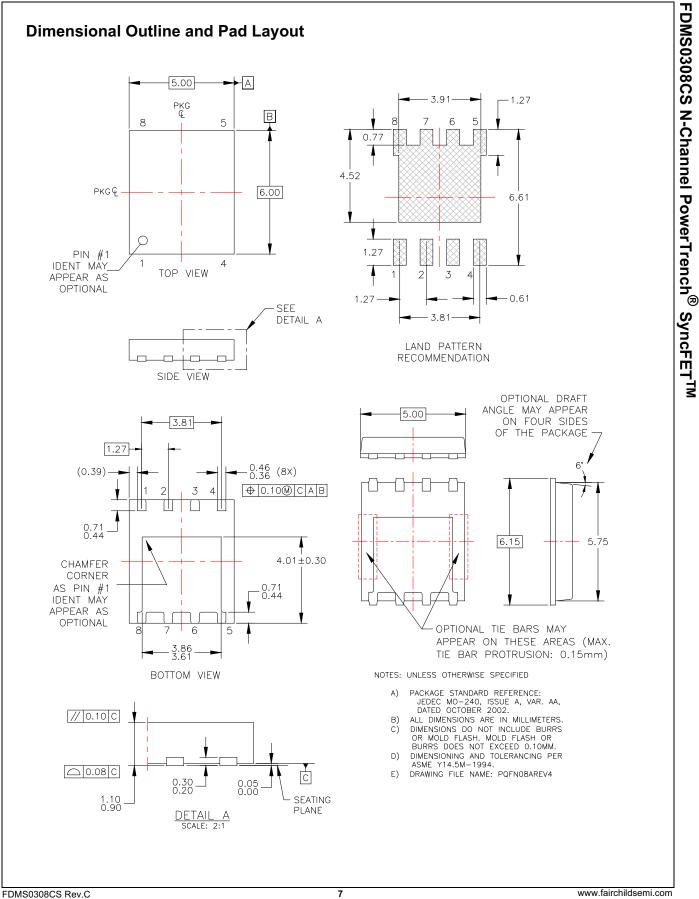


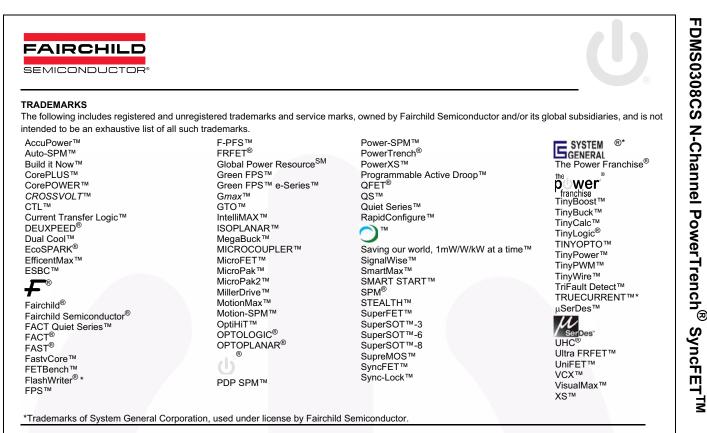
Figure 14. FDMS0308CS SyncFET body diode reverse recovery characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.









### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

### As used here in:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness

### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS
Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.
		Rey

www.fairchildsemi.com